

# CONNECTOR WITH INTEGRAL TRANSMISSION LINE BUS

## FIELD OF THE INVENTION

The present invention relates to electrical interconnects and, in particular, connectors for use in high speed electrical interfaces.

## BACKGROUND

In general, electrical connectors consist of two components, a receptacle and a plug. The receptacle is the compliant part of the connector. That is, the receptacle is fashioned in such a way that it provides compliance (or "springiness"), either through the use of a springy metal such as a Beryllium-Copper (Be—Cu) alloy or some other means. The plug then forms the non-compliant part of the connector.

Connectors are used in a variety of applications where electrical coupling between components, e.g., integrated circuits, circuit boards, etc., is desired. However, connectors for high speed interfaces are required to present controlled impedance interconnections. The interface between a Rambus DRAM (RDRAM®) and a Rambus Channel is an example of a high speed interface that requires a connector having particular electrical and physical characteristics.

Since the early 1970s, the essential characteristics of a DRAM interface have remained as a separate data bus and a multiplexed address bus. However, a recent architecture pioneered by Rambus, Inc. provides a new, high bandwidth DRAM interface. Originally, the Rambus Channel, the heart of the new DRAM interface, comprised a byte wide, 500 or 533 Mbytes/sec. bi-directional bus connecting a memory controller with a collection of RDRAMs®. Among the many innovative features of the Rambus Channel and of the RDRAM® is the use of vertically or horizontally mounted RDRAMs® and a physically constrained, bi-directional bus using terminated surface-trace transmission lines on a circuit board. The physical and electrical properties of both the RDRAMs® and bus on which they are placed are rigidly defined because high frequency operation relies on the careful physical design of both the printed circuit board and the high speed components. Originally, RDRAMs® were specified to include a 32-pin package, either a surface horizontal package (SHP) or a surface vertical package (SVP).

Electrical connectors of the past have generally been unsuitable for use in high speed bus applications such as may be found with the Rambus Channel. For example, as shown in FIG. 1, electrical connectors of the past have employed compliant contact elements 2 to receive semiconductor devices and/or circuit boards to provide electrical coupling to a circuit on a substrate 4 (e.g., a motherboard). The electrical connectors may be contained within housings 6 adapted to receive the semiconductor device or circuit board and are electrically coupled to circuit elements on the motherboard through a solder connection 8. Such a connector thus requires a number of surface mount contacts (e.g., solder contacts 8) between the contact elements 2 and the substrate 4.

Such a connector is not suitable for use in a high speed electrical bus because the contact elements 2 are individually soldered to circuit elements (e.g., electrical traces) on the substrate 4, and because the resulting solder joints 8 are generally not accessible for inspection and repair. High speed bus design dictates that the electrical signal path from device to device be kept at a minimum. Further, electrical contacts on each device should be concentrated into a small

area. Together, these requirements lead to a high density array of separable contacts, whose corresponding solder joints are made inaccessible due to interference from adjacent contacts and/or the contact housing. Except for special "ball grid array" soldering techniques, surface mount solder joints are generally required to be accessible for inspection and repair. Because connectors such as that illustrated in FIG. 1 are incapable of meeting these requirements, they are unsuitable for use in high speed bus applications.

## SUMMARY OF THE INVENTION

It is an object of the present invention to provide means for electrically coupling a number of substantially similar electrical devices in a substantially bus-like arrangement.

It is a further object of the present invention to provide an electrical connector for use in high speed applications.

A socket is described. The socket may include a first conductor having two or more contact regions and a second conductor arranged substantially parallel to the first conductor and having two or more contact regions. The first and second conductors are spaced relative to one another so as to provide a predetermined electrical impedance. A dielectric spacer may be disposed between the first and second conductors to provide the spacing. Contact regions of the first and second conductors may provide compliant coupling regions for the socket. The first conductor may be further adapted to be coupled to a substrate through only two electrical contact elements over its length, regardless of the number of contact regions of the first conductor. In addition, the second conductor may be further adapted to be coupled to the substrate through a number of electrical contact elements disposed along its length, the number of contact elements being independent of the number of contact regions of the second conductor.

Further described is an electrical connector that includes a socket and a number of conductors disposed therein. The conductors are arranged to carry electrical signals as transmission lines, and are further arranged into a first group of conductors, each adapted to be coupled to a substrate at only two electrical contact elements, and a second group of conductors each adapted to be coupled to the substrate at a plurality of electrical contact elements. The conductors may each include compliant contact regions, each arranged such that the contact regions of a first of the conductors are positioned within the socket so as to contact a lead disposed on a first side of a circuit element and the contact regions of a second of the conductors are positioned within the socket so as to contact a lead disposed on a second side of the circuit element. A dielectric spacer may be disposed between the first and second conductors.

Also described is a circuit board that includes a compliant electrical connector having a plurality of conductors arranged into a first group of conductors each adapted to be coupled to a substrate at only two electrical contact elements and a second group of conductors each adapted to be coupled to the substrate at a plurality of electrical contact elements. The circuit board further includes an electrical channel, which may include a number of traces, coupled to the connector. Each of the electrical conductors may further include two or more contact regions, the number of contact regions of each conductor being independent of the number of electrical contact elements of a respective conductor.

In addition, a connector that includes a first electrical signal path configured to provide a bus-like interconnection between similar electrical couplings of two or more electrical components, the bus-like interconnection adapted to be

isolated from a circuit board except for two electrical contact elements disposed near opposite ends of said first electrical signal path; the connector also including a ground signal path, is described. The ground signal path may be configured as a second electrical signal path arranged to provide a bus-like interconnection between similar electrical couplings of said two or more electrical components. Further, the ground signal path may be adapted to be electrically coupled to a ground plane of the circuit board at a plurality of points along said bus-like interconnection. The first electrical signal path generally includes an electrical conductor having compliant contact regions, which may include elastomer-backed metal regions or may be made of a Beryllium-Copper (Be—Cu) alloy.

Additionally described is a socket that includes a conductive signal bar having two or more contact regions, each adapted to couple to a contact region on a respective electrical device, the signal bar further adapted to be electrically coupled to a circuit board through only two electrical contact elements regardless of the number of contact regions of said signal bar. The socket also includes a conductive ground bar arranged substantially parallel to said signal bar and having two or more contact regions, each adapted to couple to a contact region on said respective electrical devices, and further being adapted to be electrically coupled to a conductive reference region of the circuit board at a number of electrical contact elements, the number of electrical contact elements being independent of the number of contact regions of the ground bar.

#### BRIEF DESCRIPTION OF THE DRAWINGS

The present invention is illustrated by way of example, and not limitation, in the Figures of the accompanying drawings, in which:

FIG. 1 illustrates a conventional electrical connector requiring an independent surface mount contact;

FIG. 2 illustrates a printed circuit board with a socket configured in accordance with one embodiment of the present invention;

FIG. 3A illustrates a cross-sectional view of the printed circuit board shown in FIG. 1 and includes features of the socket shown in FIG. 1 according to one embodiment of the present invention;

FIG. 3B illustrates a cross-sectional view of a bus conductor adapted to carry a ground signal in accordance with an embodiment of the present invention;

FIG. 4 illustrates one means of providing a desired spacing for electrical conductors within a socket according to one embodiment of the present invention;

FIG. 5 illustrates an electrical channel according to a further embodiment of the present invention;

FIG. 6A illustrates an alternative conductor with contact regions for use according to a further embodiment of the present invention;

FIG. 6B illustrates the conductor of FIG. 5A with contact regions bent to provide desired electrical characteristics in accordance with a further embodiment of the present invention;

FIG. 7 illustrates one embodiment of a Daughter card for use with a socket configured according to one embodiment of the present invention;

FIG. 8 illustrates a pair of conductors with contact regions arranged in accordance with an alternative embodiment invention;

FIG. 9 illustrates how the conductors shown in FIG. 7 provide some mechanical support for an integrated circuit

component in accordance with one embodiment of the present invention;

FIG. 10 illustrates a further embodiment of a transmission line socket configured in accordance with yet another embodiment of the present invention; and

FIG. 11 illustrates a cut-away side-view of the transmission line socket in FIG. 10.

#### DETAILED DESCRIPTION

Described herein is a socket which includes a first conductor having two or more contact regions and second conductor arranged substantially parallel to the first conductor and also having two or more contact regions. The first and second conductors are spaced relative to one another so as to provide a predetermined electrical impedance. For one embodiment, a dielectric spacer may be disposed between the first and second conductors to provide the spacing. Embodiments of the present invention may find particular use as a socket for accepting integrated circuit (IC) devices, e.g., memory devices such as RDRAMs®, or circuit boards which operate at high frequency. High frequency operation requires careful physical design and a robust electrical interface, both of which are provided by the present invention.

Because the Rambus channel operates at very high frequency with only limited voltage swings between logic levels, any new connector system requires not only a careful physical design but a robust electrical interface. Thus, embodiments of the present invention provide the physical and electrical properties needed to maintain signal integrity on the Rambus channel. At the same time, embodiments of the present invention provide a more manufacturable solution when compared with other means of coupling RDRAMs® to a printed circuit board. Of course, further embodiments of the present invention may also find application wherever a semiconductor device is to be coupled to a substrate (e.g., a motherboard) across a high speed electrical interface.

As shown in FIG. 2, a printed circuit board (PC board) 10 may include an application specific integrated circuit (ASIC) or other processing device 12. ASIC 12 may be mounted to PC board 10 using any of number of conventional integrated circuit mounting techniques. For some embodiments, ASIC 12 may be soldered directly to traces on PC board 10. Also mechanically affixed to PC board 10 is a socket 14 configured in accordance with one embodiment of the present invention. Socket 14 may be adapted to accept an RDRAM® or other Daughter card 16. Socket 14, in addition to providing a mechanical coupling for Daughter card 16, provides a electrical interface between Daughter card 16 and channel 18. Channel 18 includes a number of metal traces laid out on printed circuit board 10 using conventional printed circuit board fabrication techniques and may be configured in accordance with the Rambus Channel physical and/or electrical specifications or other high speed electrical interface requirements.

In general, printed circuit board 10 may include a number of sockets 14. Each socket 14 may be adapted to accommodate two or more Daughter cards 16. Within each socket 14, means of electrically coupling a number of Daughter cards 16 in a substantially bus-like arrangement are provided. In this context, coupling means that there is a separable electrical contact between each Daughter card 16 and the bus. The term bus, as used herein, refers to the interconnect being such that each device (i.e., each Daughter card 16) has an identical (or nearly identical) pinout layout and

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like pins of various Daughter cards 16. The spacing of plates 22 is controlled so as to provide the required unloaded electrical impedance to ensure proper operation at high frequency. FIG. 4 illustrates in more detail one means of providing the proper spacing and electrical coupling between plates. As shown, a first plate 22a and second plate 22b may be separated by a dielectric spacer 36. Each of the plates 22a and 22b may be bonded to the dielectric spacer 36 and pressed together so as to achieve the desired spacing between elements. Elastomer 26 is provided between contact regions 24 and the remainder of the plate 26 to provide compliance as described above. In other embodiments, the electrical properties provided by dielectric spacer 36 may be achieved by using an air gap between plates 22a and 22b.

In order to provide proper signal integrity, channel 18 and, hence, plates 22 within socket 14, is/are organized so that cross-talk between signal lines is reduced or eliminated. This may be achieved, in one embodiment, as illustrated in FIG. 5. As shown, the traces 20 on printed circuit board 10 which make up channel 18 are arranged in pairs of signal lines (S) and ground (AC) lines (G). That is, the traces 20 are arranged as signal, signal; ground, ground; signal, signal, etc. and are spaced at a desired distance "d" to achieve desired electrical characteristics (e.g., a desired impedance). The conductors within socket 14 carry the respective signals or grounds from channel 18.

FIG. 6A illustrates an alternative embodiment for the electrical conductors within socket 14. In this case, plates 22 have been replaced with conductors 40. Conductors 40 include contact regions 42 which are formed as taps or fingers. In general, conductors 40 may be stamped from metal and may lie flat along the bottom of socket 14. Appropriate electrical connection between traces 20 and conductors 40 is provided (e.g., using a solder connection). As shown in FIG. 6B, contact regions 42 are bent so as to form contact pads 46. Contact pads 46 may then provide electrical coupling between corresponding contact regions or pins on Daughter card 16 and conductor 40.

FIG. 7 illustrates in more detail a Daughter card 16. As shown, Daughter card 16 comprises an integrated circuit (IC) component 50, for example a DRAM chip, and a plurality of leads 52. Leads 52 extend from IC component 50 in a fan out pattern to one edge of Daughter card 16. The leads 52 may be metal traces on a suitable flexible material overlaid over a rigid support member, e.g., a metal plate. In general, leads 52 may be present on both sides of Daughter card 16 and may terminate in larger contact pads or pins.

For the situation where leads are present on both sides of Daughter card 16, an alternative electrical connection within socket 14 may be provided using conductors 60a and 60b as illustrated in FIG. 8. Conductors 60a and 60b may be formed as metal plates as for the embodiment illustrated in FIG. 3 or as essentially flat conductors as for the embodiment shown in FIG. 6A. Contact regions 62a and 62b are formed using tabs or fingers similar to the embodiment illustrated in FIGS. 6A and 6B. As shown, conductor 60a may be used for a ground signal and conductor 60b may be used as a signal carrying conductor, for example, where traces 20 (not shown) are arranged as signal, signal; ground, ground; etc. as discussed above.

In one embodiment, conductors 60a and 60b may be disposed within socket 14 so that contact region 62a makes contact with a pin or lead on one side of Daughter card 16 while conductor 62b makes contact with a pin or lead (or other contact region) on the opposite side of Daughter card 16. This arrangement is illustrated in FIG. 9. Such an

arrangement provides additional mechanical support for Daughter card 16 within socket 14.

FIG. 10 illustrates a top view of a further embodiment of a transmission line socket 70 in accordance with yet another embodiment of the present invention. Socket 70 is illustrated as a four-site socket with three signal lines 72, however, this is for purposes of example only and the present invention is applicable to a single or multiple-site socket having a plurality of signal lines. Plug-in devices (e.g., Daughter cards 16) may be accepted within any of the slots 74 and the electrical conductors 72 and 76 are arranged so that the plug-in devices are contacted by the conductors on both the front and back sides, thereby reducing the effective signal spacing on the plug-in device and easing associated mechanical tolerance requirements. Electrical conductors 72 and 76 are configured as bus bar transmission lines with solder connections at either end of socket 70.

In this embodiment, the electrical signals within socket 70 are ordered as signal, ground, signal, etc. Such a distribution aids in achieving uniform impedance and minimal crosstalk, however, it is necessary that this same signal distribution pattern be maintained not only between the conductors 72 and 76, but also between contact areas on the plug-in devices. If the electrical contact areas of the conductors 72 and 76 were arranged so as to alternate connections between the front and back sides of a plug-in device, all the signal connections (from conductors 72) would end up on one side of the plug-in device while all the ground connections (from conductors 76) would end up on the other side. This would yield poor electrical qualities because the inductive loop area would be increased, resulting in greater contact inductance.

This problem is solved in this embodiment by forming the contact regions of the conductors 72 and 76 so that each row of contacts is bent such that the point where the contact touches the plug-in device is off-set by one-half of the pitch (i.e., the distance between contact regions or pins on the plug-in device). That is, each pair of adjacent signal and ground conductors, 72 and 76, have respective contact regions bent towards one another in a vertical plane. The result is illustrated in FIG. 11 which depicts a cut-away side-view of socket 70. The effect of this forming pattern is that both sides of the plug-in device will contact in a signal, ground, signal, etc. pattern, which maintains good signal isolation and inductance characteristics. The impedance of the transmission line socket 70 may be selected by varying the width, thickness and spacing of the conductors 72 and 76, as well as the ratio of socket body material to air gap spacing separating the conductors.

To provide compliance, contact regions 62a and 62b (and conductors 60a and 60b, if desired) of FIG. 8 and/or conductors 72 and 76 of FIG. 10 may be made from a springy metal such as a Beryllium-Copper (Be—Cu) alloy or another metal. Alternatively, the contact regions may be elastomer-backed metal regions as discussed with reference to FIG. 3. In such a case, the elastomer may be supported by a wall or other region of socket 14. In other embodiments, socket 14 may be a plug (i.e., a non-compliant component of the coupling system) and a compliant coupling region may be provided on Daughter card 14.

Embodiments of the present invention avoid the one-to-one correspondence between the number of contact regions and contact elements which were found in connectors of the past. The one-to-one correspondence of contact regions to contact elements which characterized previous connectors lead to a very high density of contact elements to the